


<b>Search Notes</b>  	<b>Application/Control No.</b>  10553699	<b>Applicant(s)/Patent Under Reexamination</b>  CHAN ET AL.
	<b>Examiner</b>  SAM RIZK	<b>Art Unit</b>  2112

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
714	819	1/30/2009	SWR

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor Search	1/30/2009	SWR
EAST Search	1/30/2009	SWR
EAST Search	8/29/2009	SWR

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

/SAM RIZK/ Examiner.Art Unit 2112	
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